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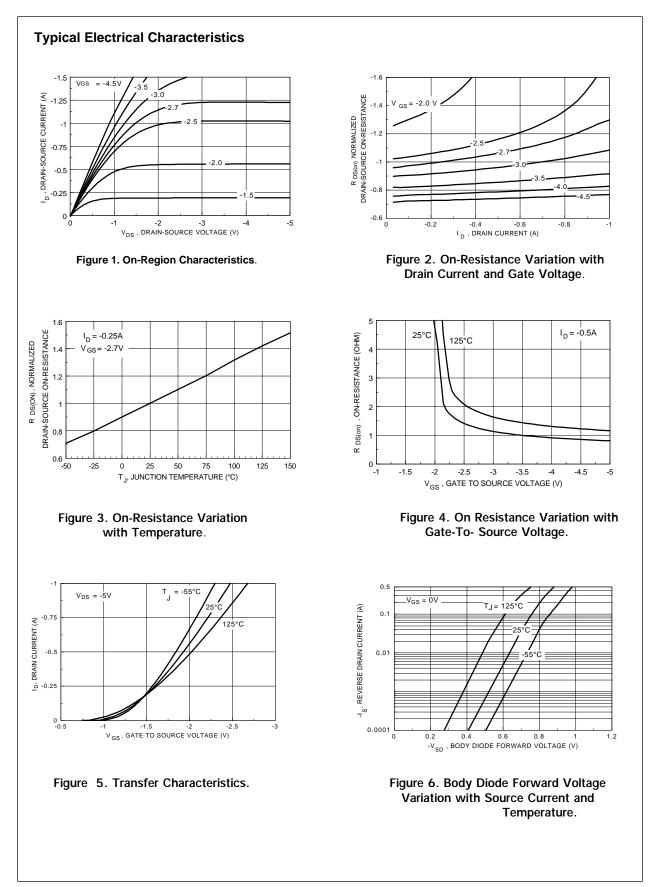
ON Semiconductor®

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| | | | | August 1997 | | | | |
|---|---|---|--|--|--|-----------------------------|--|--|
| FDV3 | | | | | | | | |
| Digita | al FET, F | P-Channel | | | | | | |
| Genera | al Descriptio | n | | Features | | | | |
| This P-Channel enhancement mode field effect transistors is produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is tailored to minimize on-state resistance at low gate drive conditions. This device is designed especially for application in battery power applications such as notebook computers and cellular phones. This device has excellent on-state resistance even at gate drive voltages as low as 2.5 volts. | | | | -25 V, -0.46 A continuous, -1.5 A Peak. R_{DS(ON)} = 1.1 Ω @ V_{GS} = -4.5 V R_{DS(ON)} = 1.5 Ω @ V_{GS} = -2.7 V. Very low level gate drive requirements allowing direct operation in 3V circuits. V_{GS(th)} < 1.5V. Gate-Source Zener for ESD ruggedness. >6kV Human Body Model | | | | |
| | | | | Compact industry standard SOT-23 surface mount package. | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | OT-23 rk:304 | SuperSOT [™] -6 | SuperSOT [™] -8 | SO-8 | SOT-223 | SOIC-16 | | |
| Mar | rk:304 | D D SOT-23 | s | | | | | |
| Absol | rk:304 | D D SOT-23 | SuperSOT [™] -8 S S | | | | | |
| Absolu | ute Maximi Parameter | D G SOT-23 G $T_{A} = 1$ | s | | G S | | | |
| Absolu | rk:304 | D G $SOT-23$ G $T_{A} = 1$ $E \text{ Voltage}$ | s | | | | | |
| Mar Absoli Symbol (DSS (GSS | ute Maximu Parameter Drain-Source | D G SOT-23 C C C C C C C C C C C C C | S S 25°C unless other wise not | | D G S FDV304P -25 -8 -0.46 | Units | | |
| Absolu Symbol (JDSS (GSS S) | ute Maximu Parameter Drain-Source Gate-Source Drain Curre | D G SOT-23 C C C C C C C C C C C C C | S S 25°C unless other wise not | | D G S FDV304P -25 -8 | Units V V V | | |
| Absolu Symbol (DSS (GSS D | rk:304 rk:304 ute Maximu Parameter Drain-Source Gate-Source Drain Curree Maximum P | D G | S S | | FDV304P -25 -8 -0.46 -1.5 | Units V V A | | |
| Absoli Symbol /pss /css /css /css /css | rk:304 rk:304 Parameter Drain-Source Gate-Source Drain Curree Maximum P Operating a Electrostatic | D G SOT-23 G um Ratings $T_A = I$ e Voltage G nt - Continu - Pulsed O ower Dissipation G | S S 25°C unless other wise not uous i e Range STD-883D | | D G S FDV304P S -25 -8 -0.46 -1.5 0.35 0.35 | Units Units V V V W W | | |
| Absoli Symbol /oss /oss | rk:304 rk:304 Parameter Drain-Source Gate-Source Drain Curree Maximum P Operating a Electrostatic | D G SOT-23 G um Ratings $T_A = 3$ e Voltage G et Voltage G et Voltage G ower Dissipation G nd Storage Temperature G Discharge Rating MII Y Model (100pf / 1500) G | S S 25°C unless other wise not uous i e Range STD-883D | | D G S FDV304P -25 -8 -0.46 -1.5 0.35 -55 to 150 -55 to 150 | Units Units V V V A W C C C | | |

| OFF CHAR | Parameter | Conditions | Min | Тур | Max | Units |
|------------------------------------|---|--|-------|-------|------|--------|
| | ACTERISTICS | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 V, I_{D} = -250 \mu A$ | -25 | | | V |
| $\Delta BV_{DSS} / \Delta T_{J}$ | Breakdown Voltage Temp. Coefficient | $I_{\rm D}$ = -250 µA, Referenced to 25 °C | | -22 | | mV /°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -20 V, V_{GS} = 0 V$ | | | -1 | μA |
| 200 | | $T_{\rm r} = 55^{\circ}{\rm C}$ | | | -10 | μA |
| I _{GSS} | Gate - Body Leakage Current | $V_{GS} = -8 V, V_{DS} = 0 V$ | | | -100 | nA |
| | CTERISTICS (Note) | 65 . 55 | | 1 | 1 | |
| $\Delta V_{GS(th)} / \Delta T_{J}$ | Gate Threshold Voltage Temp. Coefficient | $I_p = -250 \mu$ A, Referenced to 25 °C | | 2.1 | | mV /°C |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$ | -0.65 | -0.86 | -1.5 | V |
| R _{DS(ON)} | Static Drain-Source On-Resistance | $V_{GS} = -2.7 \text{ V}, \text{ I}_{D} = -0.25 \text{ A}$ | | 1.22 | 1.5 | ν Ω |
| "DS(ON) | | $V_{gs} = -4.5 \text{ V}, I_p = -0.5 \text{ A}$ | | 0.87 | 1.1 | |
| | | T ₁ =125°C | | 1.21 | 2 | |
| I _{D(ON)} | On-State Drain Current | $V_{GS} = -2.7 \text{ V}, V_{DS} = -5 \text{ V}$ | -0.5 | | | А |
| D(ON) | | $V_{gs} = -4.5 \text{ V}, V_{Ds} = -5 \text{ V}$ | -1 | | | |
| g _{FS} | Forward Transconductance | $V_{\rm DS} = -5 \text{ V}, \text{ I}_{\rm D} = -0.5 \text{ A}$ | | 0.8 | | S |
| | L CHARACTERISTICS | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz | | 63 | | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | 34 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 10 | | pF |
| | G CHARACTERISTICS (Note) | | | | 1 | |
| t _{D(on)} | Turn - On Delay Time | $V_{DD} = -6 V, I_{D} = -0.5 A,$ | | 7 | 20 | ns |
| t, | Turn - On Rise Time | $V_{\rm GS}^{\rm C}$ = -4.5 V, $R_{\rm GEN}$ = 50 Ω | | 8 | 20 | ns |
| t _{D(off)} | Turn - Off Delay Time | | | 55 | 110 | ns |
| t _f | Turn - Off Fall Time | | | 35 | 70 | ns |
| Q _g | Total Gate Charge | $V_{\rm DS} = -5 \text{ V}, \ \text{I}_{\rm D} = -0.25 \text{ A},$ | | 1.1 | 1.5 | nC |
| Q _{gs} | Gate-Source Charge | $V_{GS}^{0} = -4.5 V^{0}$ | | 0.32 | | nC |
| Q _{ad} | Gate-Drain Charge | | | 0.25 | | nC |
| DRAIN-SOU | IRCE DIODE CHARACTERISTICS AND MAXI | MUM RATINGS | | | | |
| s | Maximum Continuous Drain-Source Diode For | ward Current | | | -0.5 | А |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{\rm GS} = 0 \ V, \ I_{\rm S} = -0.5 \ A \ ({\rm Note})$ | | -0.89 | -1.2 | V |



FDV304P Rev.E1

